BAV23CLT1G, BAV23CLT3G

Dual High Voltage Common Cathode Switching Diode

Features

- Moisture Sensitivity Level: 1
- ESD Rating Human Body Model: Class 2 – Machine Model: Class C
- Fast Switching Speed
- Switching Application
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- LCD TV
- Power Supply
- Industrial

MAXIMUM RATINGS

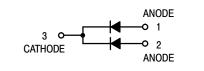
Rating	Symbol	Value	Unit
Continuous Reverse Voltage	V _R	250	V
Repetitive Peak Reverse Voltage	V _{RRM}	250	V
Peak Forward Current	١ _F	400	mA
$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	I _{FSM}	9.0 3.0 1.7	A
Peak Forward Surge Current	I _{FM(surge)}	625	mAdc
Non-Repetitive Peak Per Human Body Model Per Machine Model	HBM MM	4.0 400	kV V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



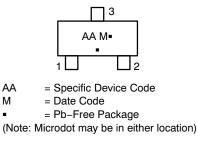
ON Semiconductor®

http://onsemi.com





MARKING DIAGRAM



ORDERING INFORMATION

Device	Package	Shipping [†]
BAV23CLT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel
BAV23CLT3G	SOT-23 (Pb-Free)	10000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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THERMAL CHARACTERISTICS

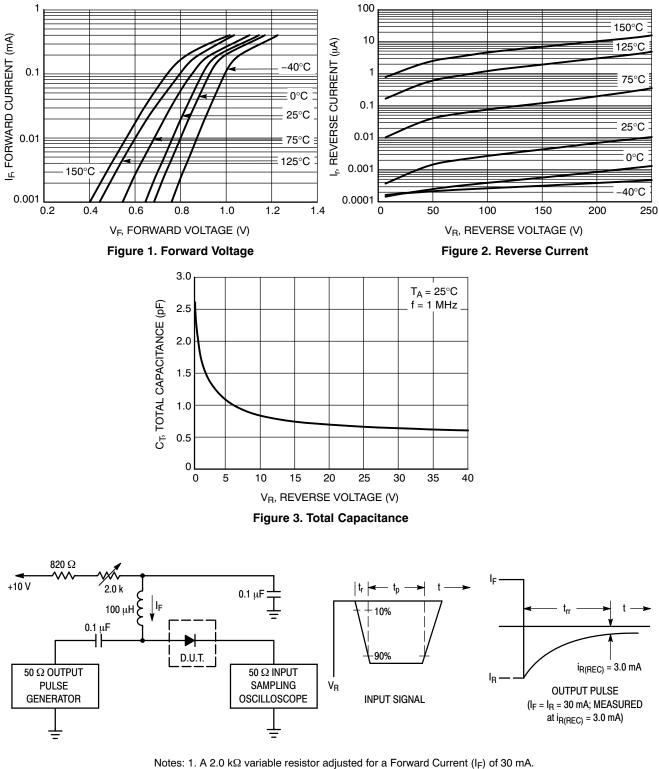
Characteristic	Symbol	Max	Unit
SINGLE HEATED		-	•
Total Device Dissipation (Note 1) T _A = 25°C Derate above 25°C	PD	265 2.1	mW mW/°C
Thermal Resistance, Junction-to-Ambient (Note 1)	R _{θJA}	472	°C/W
Thermal Reference, Junction-to-Anode Lead (Note 1)	R_ψ _{JL}	263	°C/W
Thermal Reference, Junction-to-Case (Note 1)	R_ _{yJC}	289	°C/W
Total Device Dissipation (Note 2) T _A = 25°C Derate above 25°C	PD	345 2.7	mW mW/°C
Thermal Resistance, Junction-to-Ambient (Note 2)	R _{θJA}	362	°C/W
Thermal Reference, Junction-to-Anode Lead (Note 2)	R_ψ _{JL}	251	°C/W
Thermal Reference, Junction-to-Case (Note 2)	R_ψ _{JC}	250	°C/W
DUAL HEATED (Note 3)			
Total Device Dissipation (Note 1) T _A = 25°C Derate above 25°C	PD	390 3.1	mW mW/°C
Thermal Resistance, Junction-to-Ambient (Note 1)	R _{θJA}	321	°C/W
Thermal Reference, Junction-to-Anode Lead (Note 1)	R_ψ _{JL}	159	°C/W
Thermal Reference, Junction-to-Case (Note 1)	R_ _{yJC}	138	°C/W
Total Device Dissipation (Note 2) T _A = 25°C Derate above 25°C	PD	540 4.3	mW mW/°C
Thermal Resistance, Junction-to-Ambient (Note 2)	R _{θJA}	231	°C/W
Thermal Reference, Junction-to-Anode Lead (Note 2)	R_y _{JL}	148	°C/W
Thermal Reference, Junction-to-Case (Note 2)	R_ _{yJC}	119	°C/W
Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C

FR-4 @ 100 mm², 1 oz. copper traces, still air.
FR-4 @ 500 mm², 2 oz. copper traces, still air.
Dual heated values assume total power is sum of two equally powered channels

ELECTRICAL CHARACTERISTICS (T_A = 25° C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit			
OFF CHARACTERISTICS							
Reverse Voltage Leakage Current ($V_R = 200 \text{ Vdc}$) ($V_R = 200 \text{ Vdc}$, $T_J = 150^{\circ}\text{C}$)	I _R		0.1 100	μAdc			
Reverse Breakdown Voltage (I_{BR} = 100 μ Adc)	V _(BR)	250	-	Vdc			
Forward Voltage (I _F = 100 mAdc) (I _F = 200 mAdc)	V _F		1000 1250	mV			
Diode Capacitance ($V_R = 0, f = 1.0 \text{ MHz}$)	CT	-	5.0	pF			
Reverse Recovery Time ($I_F = I_R = 30$ mAdc, $R_L = 100 \Omega$)	t _{rr}	-	150	ns			

BAV23CLT1G, BAV23CLT3G

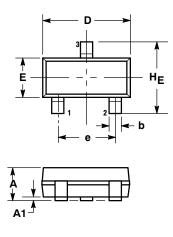


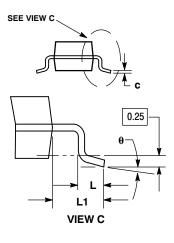
2. Input pulse is adjusted so $I_{R(peak)}$ is equal to 30 mA.

Figure 4. Recovery Time Equivalent Test Circuit

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 ISSUE AP





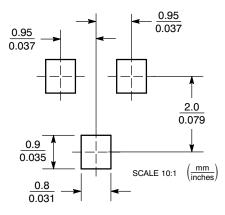
- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2
- 3.
- CONTROLLING DIMENSION: INCH. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

4.	DIME	NSIONS D	AND E	DO N	1OT	INCLU	JDE M	OLD F	FLASH,	
	PROT	FRUSIONS	, OR G	ATE B	URF	RS.				

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.89	1.00	1.11	0.035	0.040	0.044
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.37	0.44	0.50	0.015	0.018	0.020
c	0.09	0.13	0.18	0.003	0.005	0.007
D	2.80	2.90	3.04	0.110	0.114	0.120
Ш	1.20	1.30	1.40	0.047	0.051	0.055
е	1.78	1.90	2.04	0.070	0.075	0.081
L	0.10	0.20	0.30	0.004	0.008	0.012
L1	0.35	0.54	0.69	0.014	0.021	0.029
ΗE	2.10	2.40	2.64	0.083	0.094	0.104
θ	0°		10°	0°		10°

STYLE 9: PIN 1. ANODE 2. ANODE 3. CATHO CATHODE

SOLDERING FOOTPRINT



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